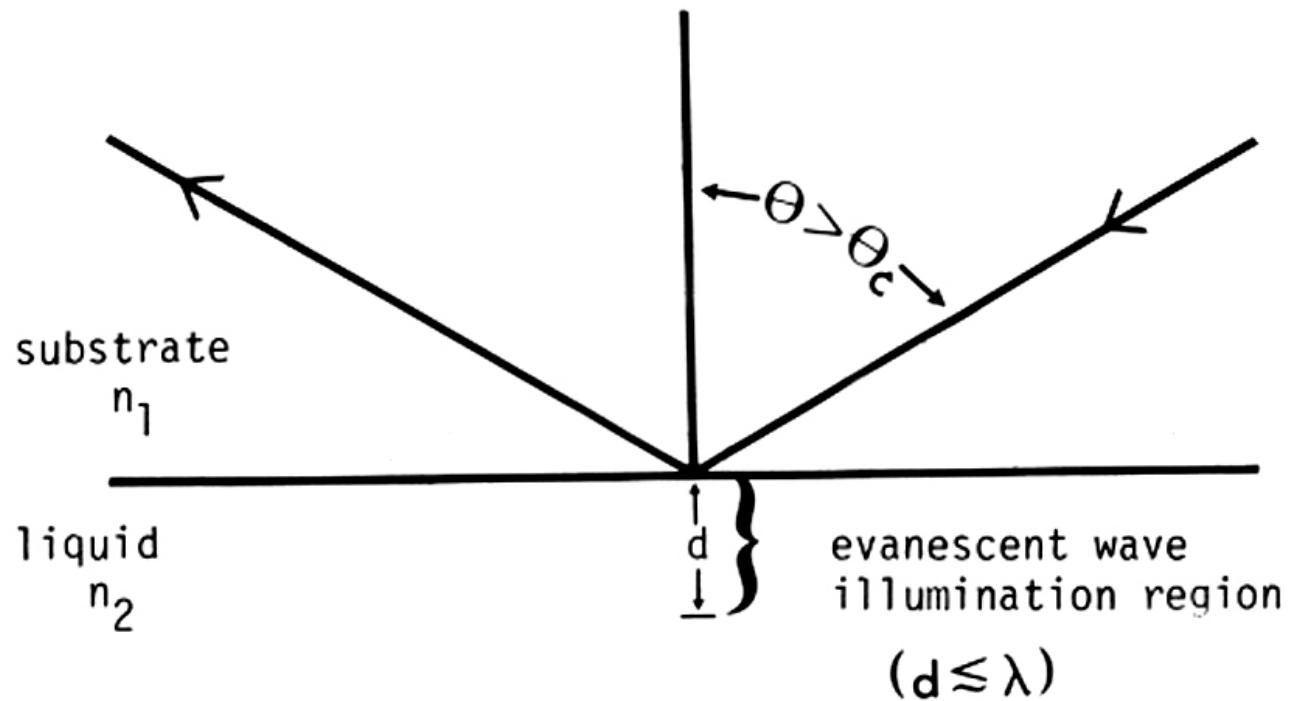
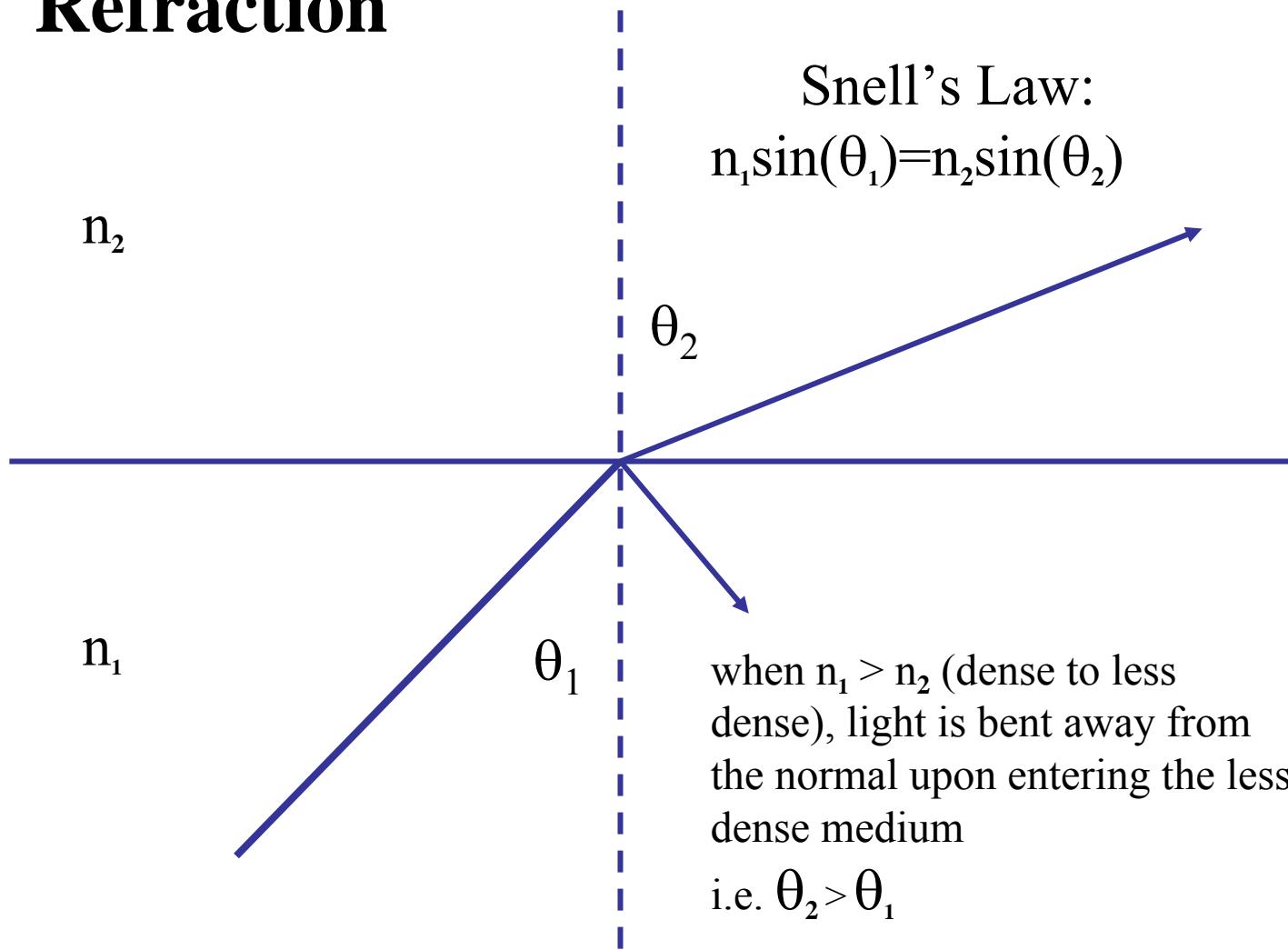


TIRF: total internal reflectance fluorescence microscopy

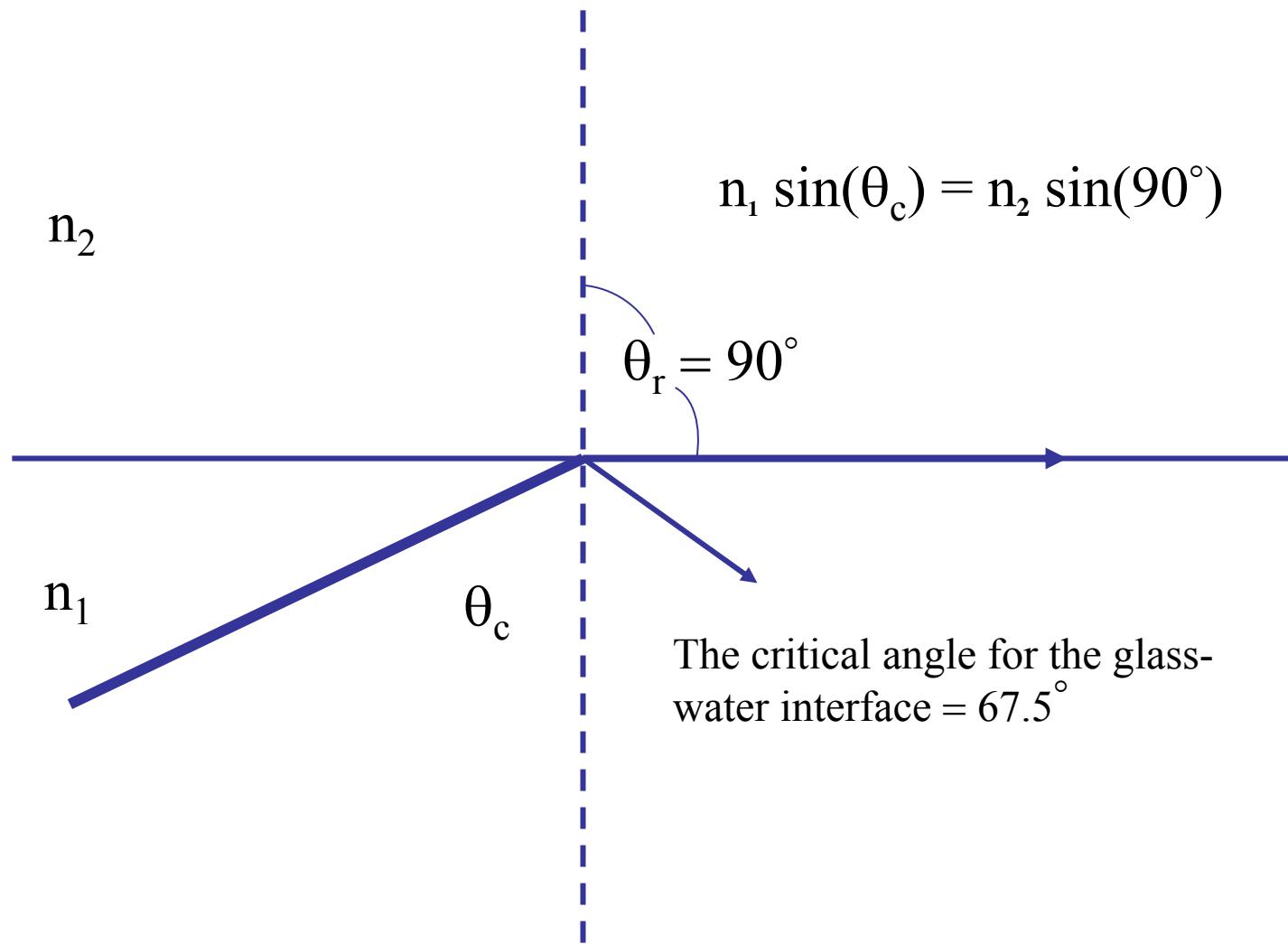
TIRF (Axelrod and coworkers)



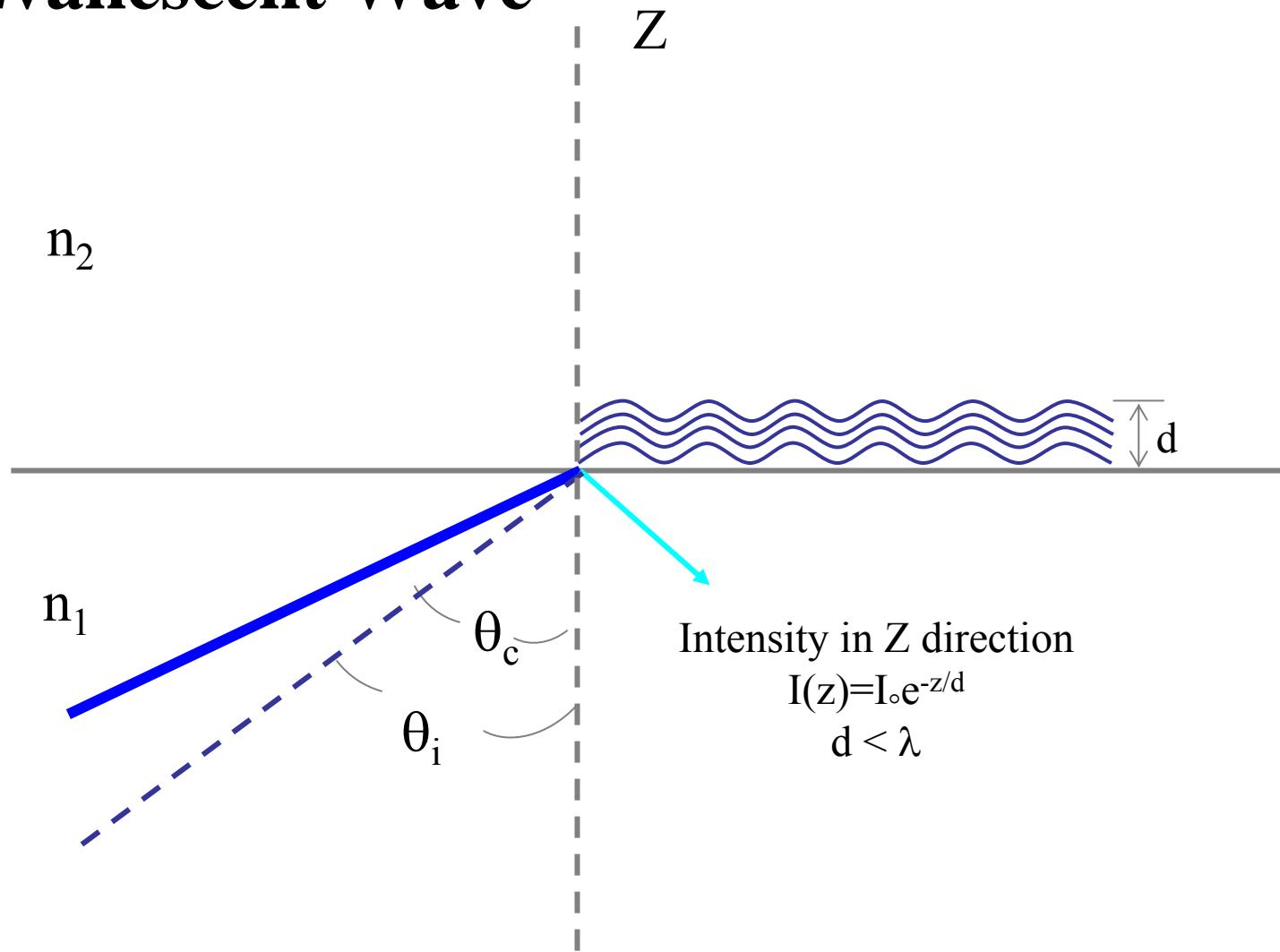
Refraction



Total internal reflection and the critical angle



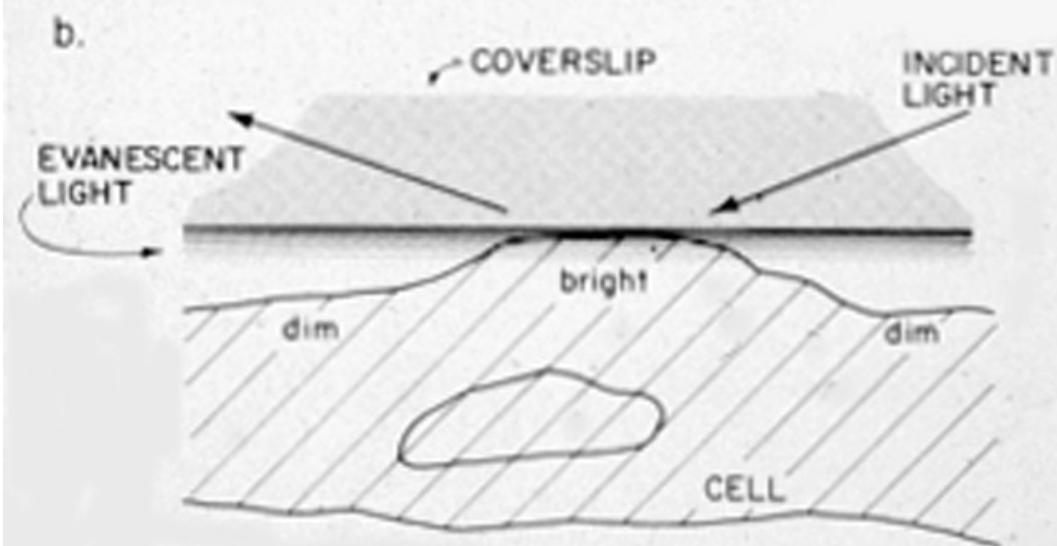
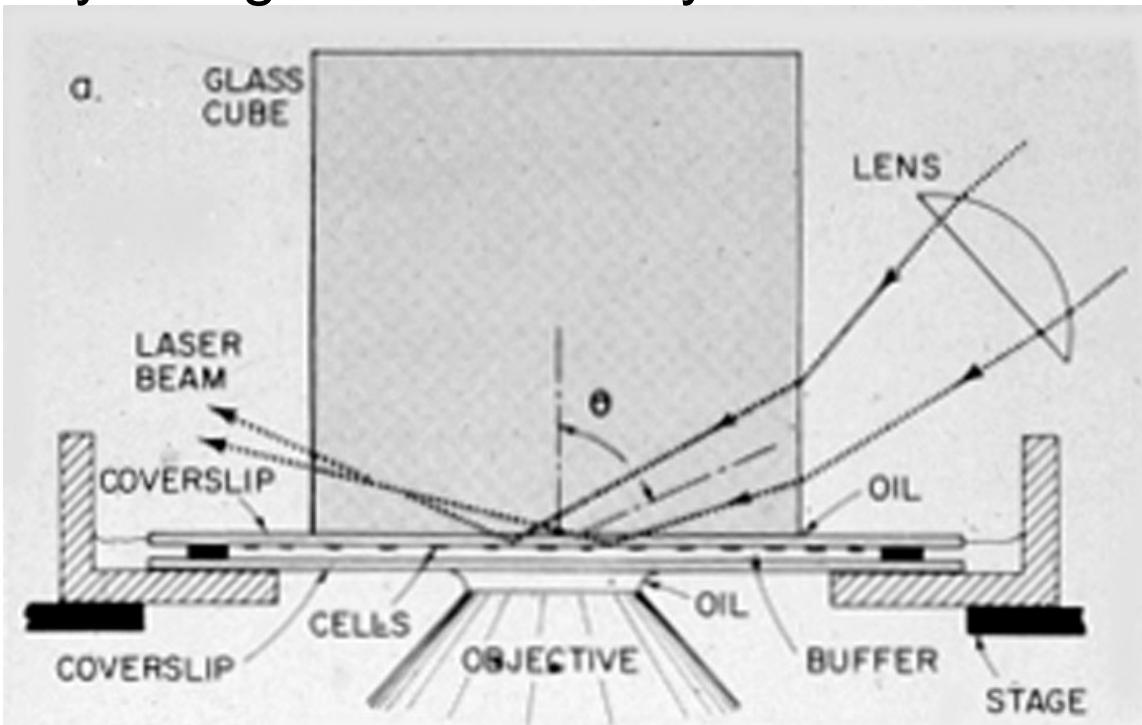
Evanescent Wave



Depth of evanescent wave (d) depends on angle of incidence, θ_i : it is largest close to the critical angle, θ_c

$$d = \frac{1}{\sqrt{\frac{\sin^2 \theta_i - 1}{\sin^2 \theta_c}}} \times \frac{\lambda}{4\pi n}$$

Early design circa 1980 by Dan Axelrod



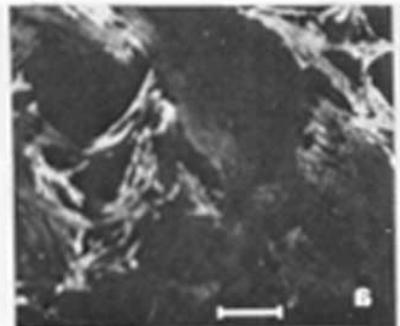
74.3 deg;
d=105nm



74.3 deg; d=405nm



micrographs show the same field at two different phase contrast settings. At 74.3 deg; d=105 nm, the cells appear relatively clear and individual cell boundaries are visible. At 74.3 deg; d=405 nm, the cells appear darker and more confluent, with less distinct boundaries between individual cells.



72.5 deg; d=120nm



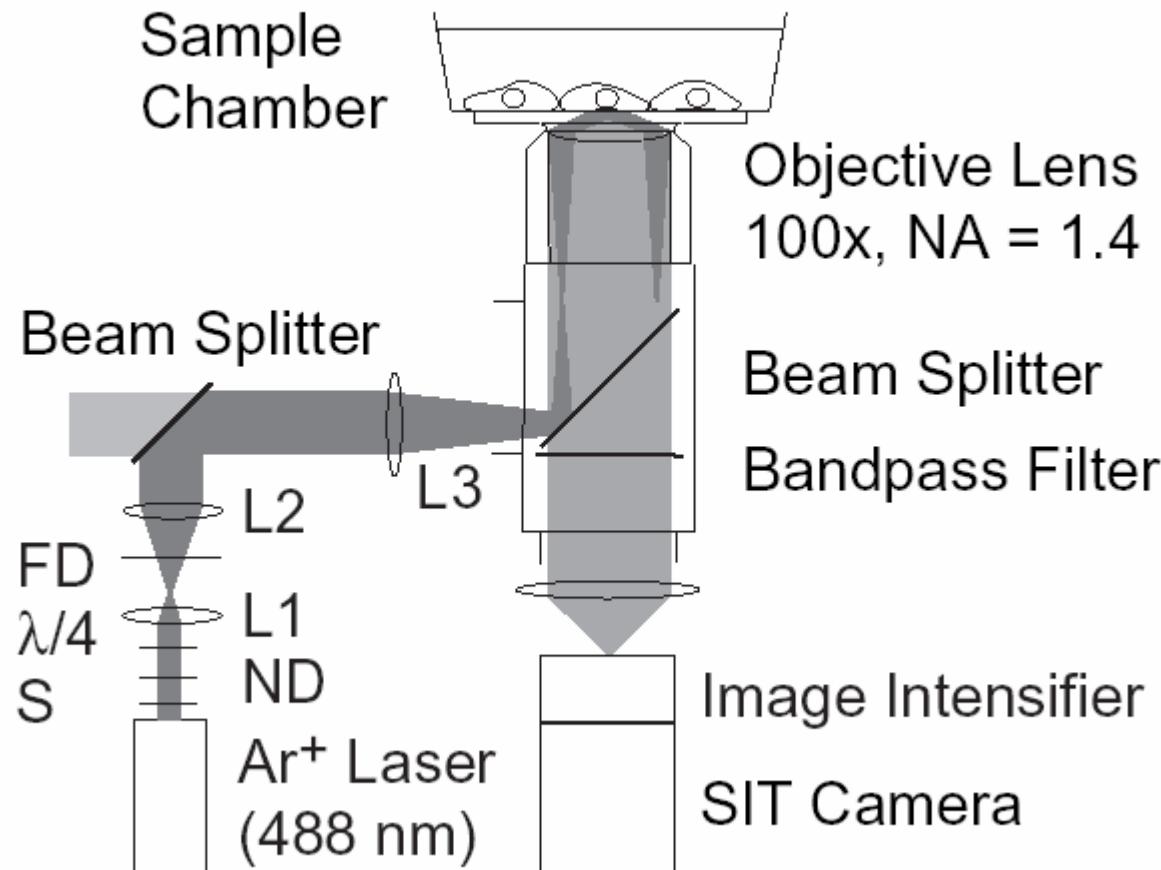
epi



phase

TIRF excitation using the objective

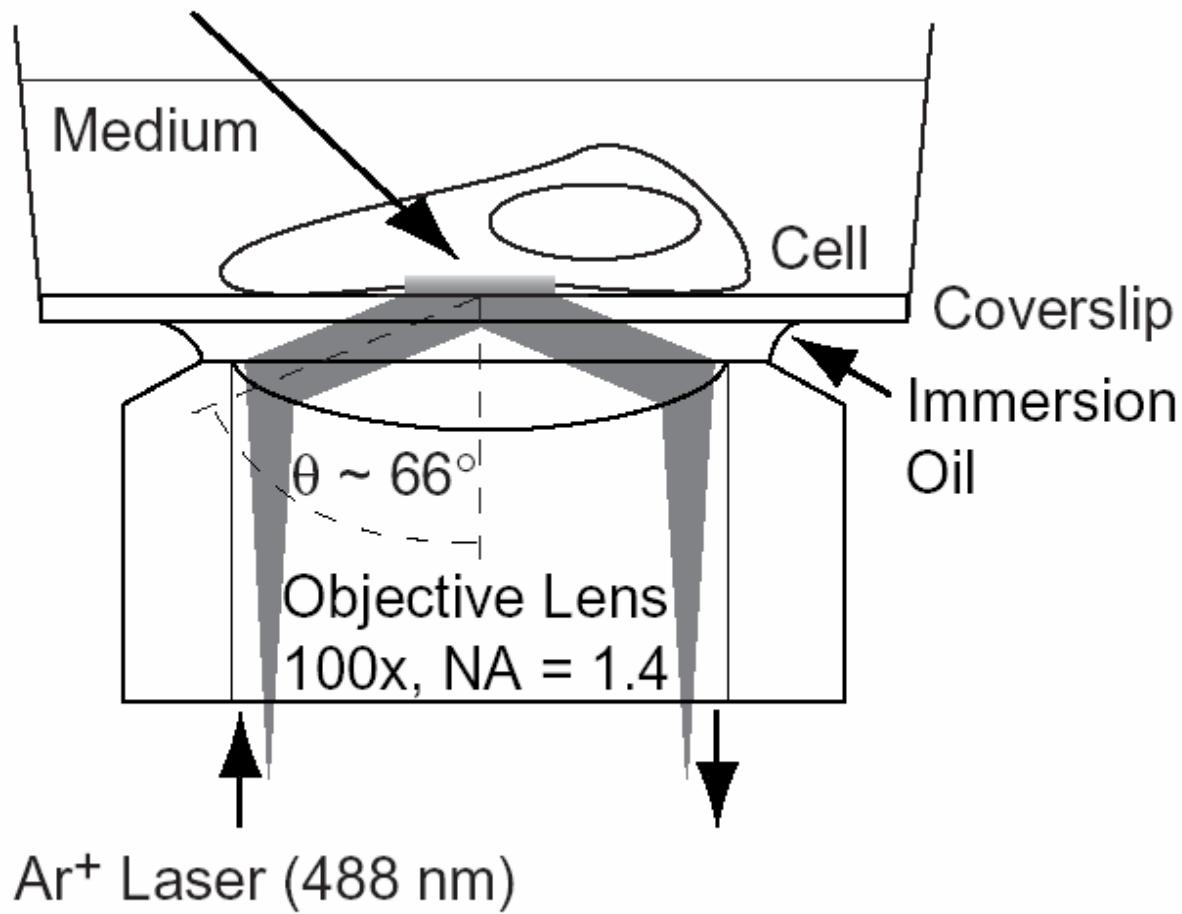
A



Iino and Kusumi, J. Fluorescence (2001)

B

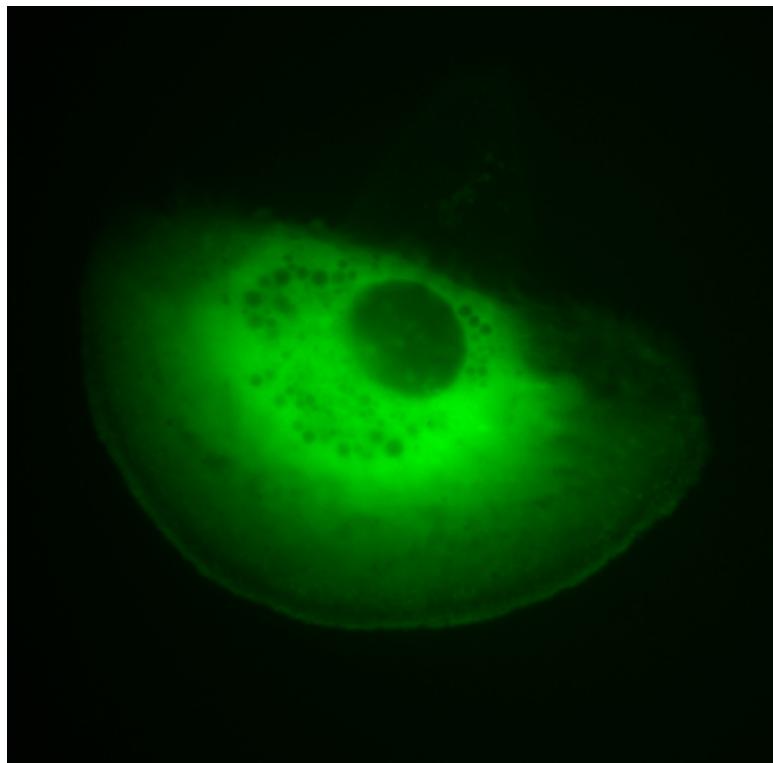
Evanescence Field ($d_{1/e} \sim 100$ nm, $\phi \sim 13$ μm)



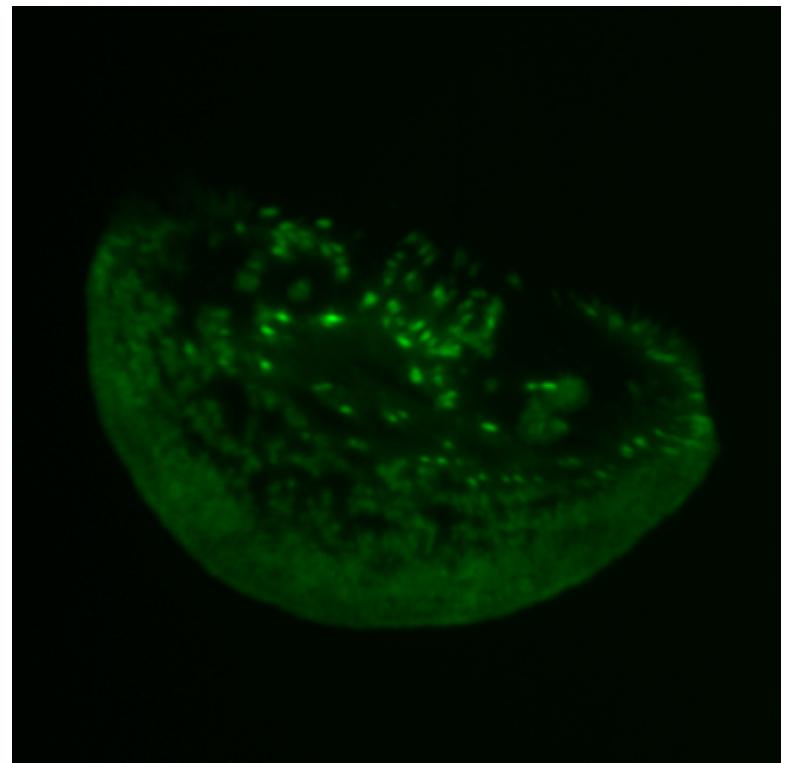
Iino and Kusumi, J. Fluorescence (2001)

Expression of EGFP-paxillin Mutant in MDA-MB-231
Human Breast Cancer Cells
Olympus 60x, 1.45 NA

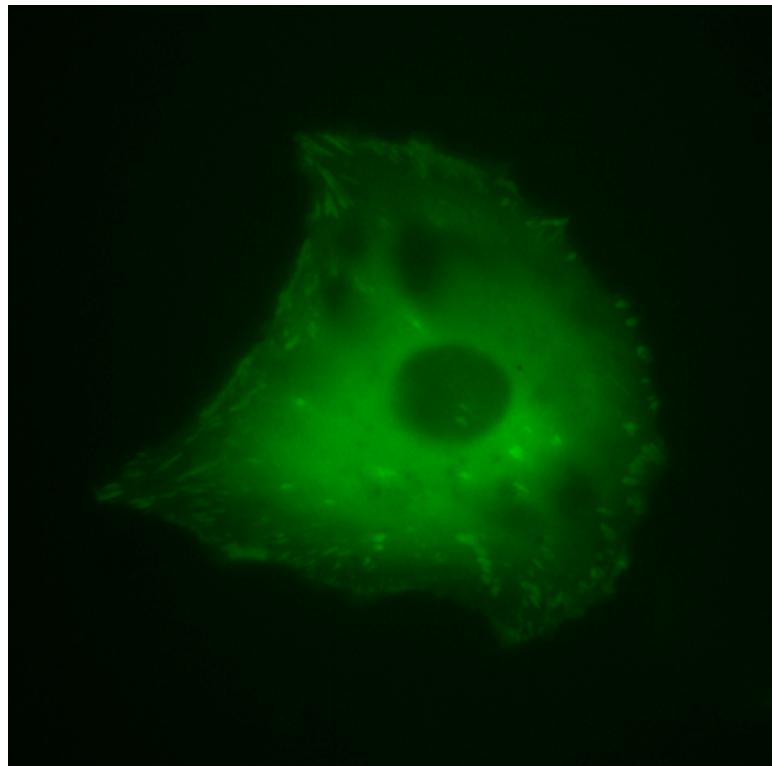
EPI
EGFP



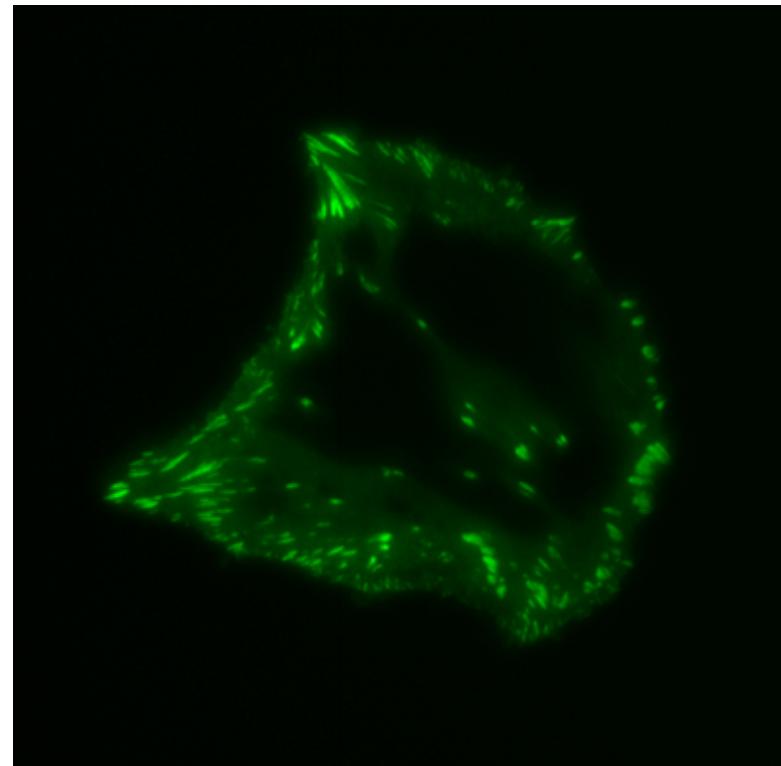
TIRF



EPI



TIRF



Single molecule studies using TIRF

Yanagida et al Nature 374: 555
(1995)

